

## EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	906	430/312.ccls.	USPAT	OR	OFF	2006/02/28 09:23
S2	1670	430/313.ccls.	USPAT	OR	OFF	2006/02/27 11:13
S3	990259	Resolution Limit	USPAT	OR	OFF	2006/02/28 09:57
S4	389667	Spacing	USPAT	AND	OFF	2006/02/28 09:24
S5	274449	Semiconductor Device	USPAT	AND	OFF	2006/02/28 09:25
S6	103815	S3 and S5	USPAT	AND	OFF	2006/02/28 09:25
S7	18610	S6 and S4	USPAT	OR	OFF	2006/02/28 09:26
S8	2189320	Line Width	USPAT	OR	OFF	2006/02/28 09:26
S9	205703	S5 and S8	USPAT	AND	OFF	2006/02/28 09:27
S10	79923	Semiconductor Device and Line Width	USPAT	AND	OFF	2006/02/28 09:28
S11	17275	Semiconductor Device and Line Width and Spacing	USPAT	AND	OFF	2006/02/28 09:28
S12	0	430/316.ccls	USPAT	OR	OFF	2006/02/28 09:56
S13	394	430/316.ccls.	USPAT	OR	OFF	2006/02/28 13:19
S14	276372	photoresist or resist or photosensitive	USPAT	OR	OFF	2006/02/28 13:20
S15	2990192	First or upper	USPAT	OR	OFF	2006/02/28 13:20
S16	3035005	second or lower	USPAT	OR	OFF	2006/02/28 13:21
S17	7648	S15 adj S14	USPAT	ADJ	OFF	2006/02/28 13:22
S18	6643	S16 adj S14	USPAT	ADJ	OFF	2006/02/28 13:23
S19	4724	S17 and S18	USPAT	AND	OFF	2006/02/28 13:24
S20	9197	bilayer	USPAT	OR	OFF	2006/02/28 13:24
S21	89	S19 and S20	USPAT	AND	OFF	2006/02/28 13:26
S22	214933	etch\$4	USPAT	OR	OFF	2006/02/28 13:26
S23	2103178	strip\$4 or remov\$4	USPAT	OR	OFF	2006/02/28 13:27
S24	1425326	block\$4 or insult\$4 or (ARC or antireflect\$4)	USPAT	OR	OFF	2006/02/28 13:27
S25	231497	resolution	USPAT	OR	OFF	2006/02/28 13:28
S26	19379	line adj width	USPAT	OR	OFF	2006/02/28 13:28
S27	19379	line adj width	USPAT	ADJ	OFF	2006/02/28 13:29
S28	30	S21 and S22 and S23 and S24 and S25	USPAT	SAME	OFF	2006/02/28 13:30